

Notice of References Cited	Application/Control No. 10/564,469	Applicant(s)/Patent Under Reexamination SHIBATA ET AL.	
	Examiner Claire L. Rademaker	Art Unit 1795	Page 1 of 1

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	V	IPDL Machine Translation and Abstract in English of JP 11-354143.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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